

Search Notes

Application/Control No.

10/764,374

Examiner

Chen-Wen Jiang

Applicant(s)/Patent under
Reexamination

SATOH ET AL.

Art Unit

3744

SEARCHED

Class	Subclass	Date	Examiner
62	238.7		
237	2B		
203	11	3/28/2006	CJ

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Searched Inventor Searched	3/28/2006	CJ